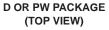
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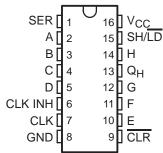
- Qualified for Automotive Applications
- ESD Protection Exceeds 2000 V Per MIL-STD-883, Method 3015; Exceeds 200 V Using Machine Model (C = 200 pF, R = 0)
- Wide Operating Voltage Range of 2 V to 6 V
- Outputs Can Drive Up To 10 LSTTL Loads
- Low Power Consumption, 80-μA Max I_{CC}
- Typical t_{pd} = 13 ns
- ±4-mA Output Drive at 5 V

description/ordering information

This parallel-in or serial-in, serial-out register features gated clock (CLK, CLK INH) inputs and an overriding clear (CLR) input. The parallel-in or serial-in modes are established by the shift/load

- Low Input Current of 1 μA Max
- Synchronous Load
- Direct Overriding Clear
- Parallel-to-Serial Conversion





(SH/LD) input. When high, SH/LD enables the serial (SER) data input and couples the eight flip-flops for serial shifting with each clock (CLK) pulse. When low, the parallel (broadside) data inputs are enabled, and synchronous loading occurs on the next clock pulse. During parallel loading, serial data flow is inhibited. Clocking is accomplished on the low-to-high-level edge of CLK through a 2-input positive-NOR gate, permitting one input to be used as a clock-enable or clock-inhibit function. Holding either CLK or CLK INH high inhibits clocking; holding either low enables the other clock input. This allows the system clock to be free running, and the register can be stopped on command with the other clock input. CLK INH should be changed to the high level only when CLK is high. $\overline{\text{CLR}}$ overrides all other inputs, including CLK, and resets all flip-flops to zero.

ORDERING INFORMATION†

TA	PACKAGE [‡]		ORDERABLE PART NUMBER	TOP-SIDE MARKING	
40°C to 95°C	SOIC - D	Tape and reel	SN74HC166AIDRQ1	HC166AI	
-40°C to 85°C	TSSOP - PW	Tape and reel	SN74HC166AIPWRQ1	HC166AI	

[†] For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI web site at http://www.ti.com.



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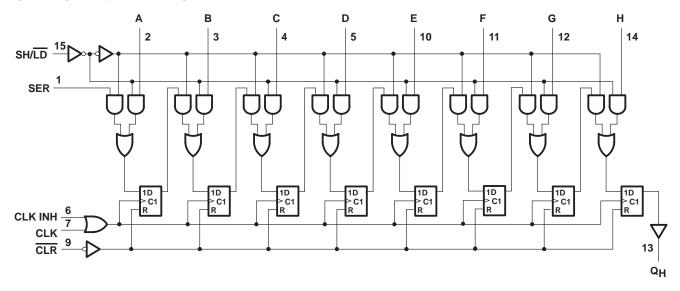
[‡]Package drawings, thermal data, and symbolization are available at http://www.ti.com/packaging.

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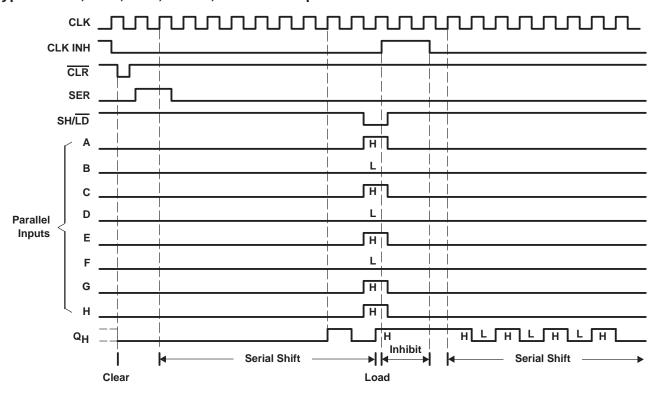
FUNCTION TABLE

	INDITE							S
	INPUTS						RNAL	
CLR	SH/LD	CLK INH	CLK	SER	PARALLEL AH	Q _A	QB	QH
L	Х	Х	Χ	Χ	Χ	L	L	L
Н	X	L	L	Χ	Χ	Q _{A0}	Q_{B0}	Q _{H0}
Н	L	L	\uparrow	Χ	ah	а	b	h
Н	Н	L	\uparrow	Н	X	Н	Q_{An}	Q _{Gn}
Н	Н	L	\uparrow	L	Χ	L	Q_{An}	Q_{Gn}
Н	Χ	Н	\uparrow	Χ	X	Q_{A0}	Q_{B0}	Q _{H0}

logic diagram (positive logic)



typical clear, shift, load, inhibit, and shift sequence



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V _{CC}	\dots -0.5 V to 7 V
Input clamp current, $I_{ K }(V_{ } < 0 \text{ or } V_{ } > V_{CC})$ (see Note 1)	$\dots \dots \pm 20 \; mA$
Output clamp current, I _{OK} (V _O < 0 or V _O > V _{CC}) (see Note 1)	$\dots \dots \pm 20 \; mA$
Continuous output current, I_O ($V_O = 0$ to V_{CC})	±25 mA
Continuous current through V _{CC} or GND	$\dots \dots \pm 50 \; mA$
Package thermal impedance, θ _{JA} (see Note 2): D package	73°C/W
PW package	108°C/W
Storage temperature range, T _{Stg}	. -65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

2. The package thermal impedance is calculated in accordance with JESD 51-7.



SN74HC166A-Q1 8-BIT PARALLEL-LOAD SHIFT REGISTER

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recommended operating conditions (see Note 3)

			MIN	NOM	MAX	UNIT
VCC	Supply voltage		2	5	6	V
		V _{CC} = 2 V	1.5			
\vee_{IH}	High-level input voltage	V _{CC} = 4.5 V	3.15			V
		V _{CC} = 6 V	4.2			
		V _{CC} = 2 V			0.5	
VIL	Low-level input voltage	V _{CC} = 4.5 V			1.35	V
		V _{CC} = 6 V			1.8	
٧ _I	Input voltage		0		VCC	V
VO	Output voltage		0		VCC	V
		V _{CC} = 2 V			1000	
$\Delta t/\Delta v^{\dagger}$	Input transition rise/fall time	$V_{CC} = 4.5 \text{ V}$			500	ns
		V _{CC} = 6 V			400	
T _A	Operating free-air temperature		-40		85	°C

[†] If this device is used in the threshold region (from $V_{IL}max = 0.5 \text{ V}$ to $V_{IH}min = 1.5 \text{ V}$), there is a potential to go into the wrong state from induced grounding, causing double clocking. Operating with the inputs at $t_t = 1000 \text{ ns}$ and $V_{CC} = 2 \text{ V}$ does not damage the device; however, functionally, the CLK inputs are not ensured while in the shift, count, or toggle operating modes.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

	TTOT COURTIONS		.,	T _A = 25°C					
PARAMETER	TEST COND	OTTIONS	VCC	MIN	TYP	MAX	MIN	MAX	UNIT
			2 V	1.9	1.998		1.9		
		$I_{OH} = -20 \mu A$	4.5 V	4.4	4.499		4.4		
Voн	VI = VIH or VIL		6 V	5.9	5.999		5.9		V
		$I_{OH} = -4 \text{ mA}$	4.5 V	3.98	4.3		3.84		
		$I_{OH} = -5.2 \text{ mA}$	6 V	5.48	5.8		5.34		
			2 V		0.002	0.1		0.1	
		$I_{OL} = 20 \mu A$	4.5 V		0.001	0.1		0.1	
V_{OL}			6 V		0.001	0.1		0.1	V
		$I_{OL} = 4 \text{ mA}$	4.5 V		0.17	0.26		0.33	
		$I_{OL} = 5.2 \text{ mA}$	6 V		0.15	0.26		0.33	
lį	$V_I = V_{CC}$ or 0		6 V		±0.1	±100	=	±1000	nA
Icc	$V_I = V_{CC}$ or 0,	I _O = 0	6 V			8		80	μΑ
C _i			2 V to 6 V	·	3	10		10	pF

NOTE 3: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

SN74HC166A-Q1 8-BIT PARALLEL-LOAD SHIFT REGISTER

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timing requirements over recommended operating free-air temperature range (unless otherwise noted)

				T _A =	25°C			
			VCC	MIN	MAX	MIN	MAX	UNIT
			2 V		6		5	
fclock	Clock frequency				31		25	MHz
		6 V		36		29		
			2 V	100		125		
		CLR low	4.5 V	20		25		
t _W	Pulse duration		6 V	17		21		ns
W	ruise duration		2 V	80		100		115
		CLK high or low	4.5 V	16		20		
			6 V	14		17		
			2 V	145		180		
		SH/LD high before CLK↑	4.5 V	29		36		
			6 V	25		31		
			2 V	80		100		
		SER before CLK↑	4.5 V	16		20		
			6 V	14		17		
			2 V	100		125		ns
t _{su}	Setup time	CLK INH low before CLK↑	4.5 V	20		25		
			6 V	17		21		
				80		100		
		Data before CLK↑	4.5 V	16		20		1
				14		17		
		CLR inactive before CLK↑		40		50		
				8		10		
			6 V	7		9		
			2 V	0		0		
		SH/LD high after CLK↑	4.5 V	0		0		
			6 V	0		0		
			2 V	5		5		
		SER after CLK↑	4.5 V	5		5		
			6 V	5		5		
th	Hold time		2 V	0		0		ns
		CLK INH high after CLK↑		0		0		
			4.5 V 6 V	0		0		
			2 V	5		5		
		Data after CLK↑	4.5 V	5		5		
			6 V	5		5		



SN74HC166A-Q1 8-BIT PARALLEL-LOAD SHIFT REGISTER

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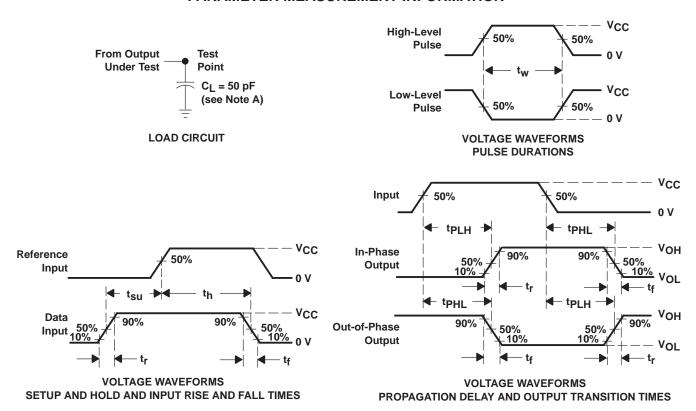
switching characteristics over recommended operating free-air temperature range, C_L = 50 pF (unless otherwise noted) (see Figure 1)

DADAMETED	FROM	то	\ ,	T,	Վ = 25° C	;	BAINI BAINY	MAY	
PARAMETER	(INPUT)	(OUTPUT)	VCC	MIN	TYP	MAX	MIN	MAX	UNIT
			2 V	6	11		5		
f _{max}			4.5 V	31	36		25		MHz
			6 V	36	45		29		
			2 V		62	120		150	
^t PHL	CLR	QH	4.5 V		18	24		30	ns
			6 V		13	20		26	
			2 V		75	150		190	
^t pd	CLK	QH	4.5 V		15	30		38	ns
·			6 V		13	26		32	
		Any	2 V		38	75		95	
t _t			4.5 V		8	15		19	ns
			6 V		6	13		16	

operating characteristics, $T_A = 25^{\circ}C$

	PARAMETER	TEST CONDITIONS	TYP	UNIT
C _{pd}	Power dissipation capacitance	No load	50	pF

PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_I includes probe and test-fixture capacitance.

- B. Phase relationships between waveforms were chosen arbitrarily. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, $Z_O = 50 \ \Omega$, $t_f = 6 \ ns$, $t_f = 6 \ ns$.
- C. For clock inputs, f_{max} is measured when the input duty cycle is 50%.
- D. The outputs are measured one at a time with one input transition per measurement.
- E. tpLH and tpHL are the same as tpd.

Figure 1. Load Circuit and Voltage Waveforms

www.ti.com 30-Jun-2025

PACKAGING INFORMATION

Orderable part number	Status	Material type	Package Pins	Package qty Carrier	RoHS	Lead finish/ Ball material	MSL rating/ Peak reflow	Op temp (°C)	Part marking (6)
						(4)	(5)		
SN74HC166AIDRQ1	Active	Production	SOIC (D) 16	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HC166AI
SN74HC166AIDRQ1.A	Active	Production	SOIC (D) 16	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HC166AI
SN74HC166AIPWRG4Q1	Active	Production	TSSOP (PW) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	HC166AI
SN74HC166AIPWRG4Q1.A	Active	Production	TSSOP (PW) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	HC166AI

⁽¹⁾ Status: For more details on status, see our product life cycle.

- (3) RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.
- (4) Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.
- (5) MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.
- (6) Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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⁽²⁾ Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

PACKAGE OPTION ADDENDUM

www.ti.com 30-Jun-2025

• Enhanced Product : SN74HC166A-EP

NOTE: Qualified Version Definitions:

• Enhanced Product - Supports Defense, Aerospace and Medical Applications

D (R-PDS0-G16)

PLASTIC SMALL OUTLINE



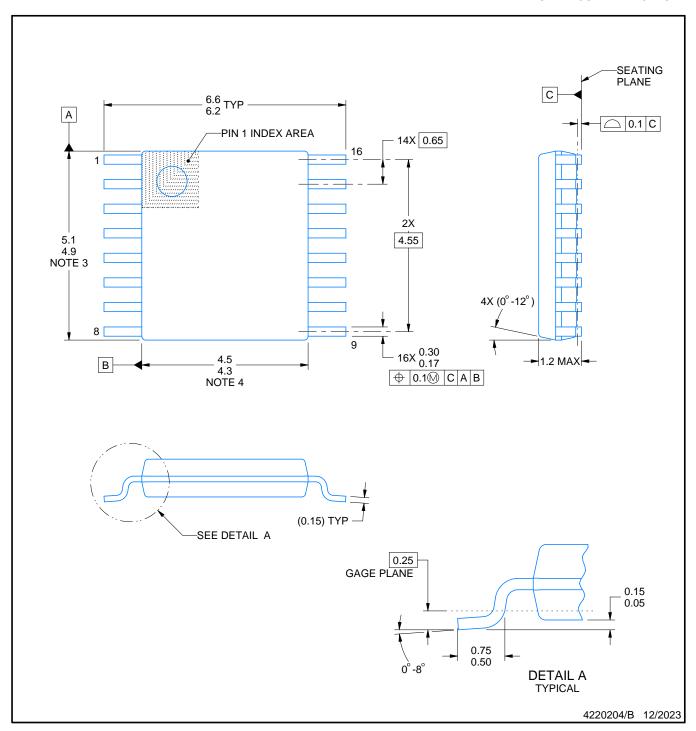
NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AC.





SMALL OUTLINE PACKAGE



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



SMALL OUTLINE PACKAGE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE PACKAGE



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



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